### FC8J33040L

## FC8J33040L Dual N-channel MOSFET

### For switching

#### Features

- Low drain-source ON resistance:Rss(on)typ. = 48 m $\Omega$  (VGS = 4.5V)
- High-speed switching :Qg = 2.8 nC
- Halogen-free / RoHS compliant
- (EU RoHS / UL-94 V-0 / MSL:Level 1 compliant)
- Marking Symbol: 7A

■ Basic Part Number Dual Nch MOS 33V (Individual)

#### Packaging

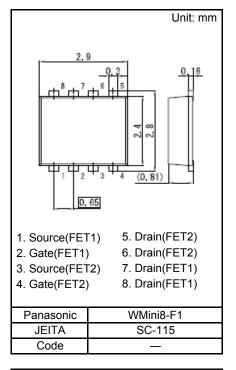
FC8J33040L Embossed type (Thermo-compression sealing): 3 000 pcs / reel (standard)

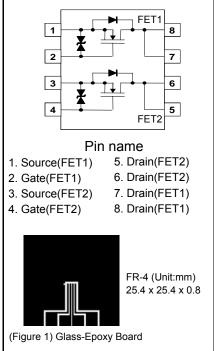
#### ■ Absolute Maximum Ratings Ta = 25°C

	Parameter	Symbol	Rating	Unit	
FET1 FET2	Drain-source Voltage	VDS	33	V	
	Gate-source Voltage	VGS	±20	V	
	Drain Current (Steady State) <sup>*1</sup>	ID	5		
	Drain Current (t=10s) <sup>*1</sup>	U	5.5		
	Drain Current (Pulsed) *1,2	IDp	20	А	
	Source Current (Pulsed)	ISp	5		
	(Body Diode) <sup>*1,2</sup>	(BD)	5		
Overall	Power Dissipation (Steady State) *1	PD	1	w	
	Power Dissipation (t=10s) *1		1.3	vv	
	Channel Temperature	Tch	150	°C	
	Storage Temperature Range	Tstg	-55 to +150	°C	

Note \*1 Device mounted on a glass-epoxy board (See Figure 1)

\*2 Pulse test: Ensure that the channel temperature does not exceed 150 °C





#### ■ Electrical Characteristics Ta = 25°C±3°C FET1, FET2

#### Static Characteristics

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Drain-source Breakdown Voltage	VDSS	ID = 1 mA, VGS = 0 V	33			V
Zero Gate Voltage Drain Current	IDSS	VDS = 33 V, VGS = 0 V			1	μA
Gate-source Leakage Current	IGSS	VGS = ±16 V, VDS = 0 V			±10	μA
Gate-source Threshold Voltage	Vth	ID = 0.26 mA, VDS = 10 V	1		2.5	V
Drain course On state Desistance *1	RDS(on)	ID = 2.5 A, VGS = 10 V		32	38	mΩ
Drain-source On-state Resistance *1		ID = 2.5 A, VGS = 4.5 V		48	68	11152

Note \*1 Pulse test: Ensure that the channel temperature does not exceed 150  $^\circ\text{C}$ 

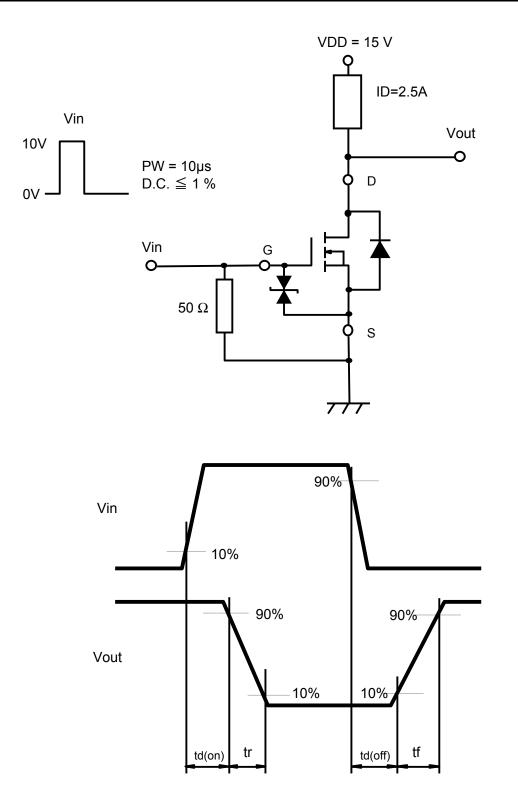
#### **Dynamic Characteristics**

Input Capacitance	Ciss		220	
Output Capacitance	Coss	VDS = 10 V, VGS = 0 V, f = 1 MHz	40	pF
Reverse Transfer Capacitance	Crss		35	
Turn-On Delay Time	td(on)	VDD = 15 V, VGS = 0 to 10 V	7	
Rise Time	tr	ID = 2.5 A (See Figure 2)	3	ns
Turn-Off Delay Time	td(off)	VDD = 15 V, VGS = 10 to 0 V	15	115
Fall Time	tf	ID = 2.5 A (See Figure 2)	9	
Total Gate Charge	Qg	VDD = 15 V, VGS = 0 to 4.5 V,	2.8	
Gate to Source Charge	Qgs	ID = 15 V, VGS = 0.004.5 V, ID = 5 A	1.1	nC
Gate to Drain Charge	Qgd		1.2	

#### Body Diode Characteristic

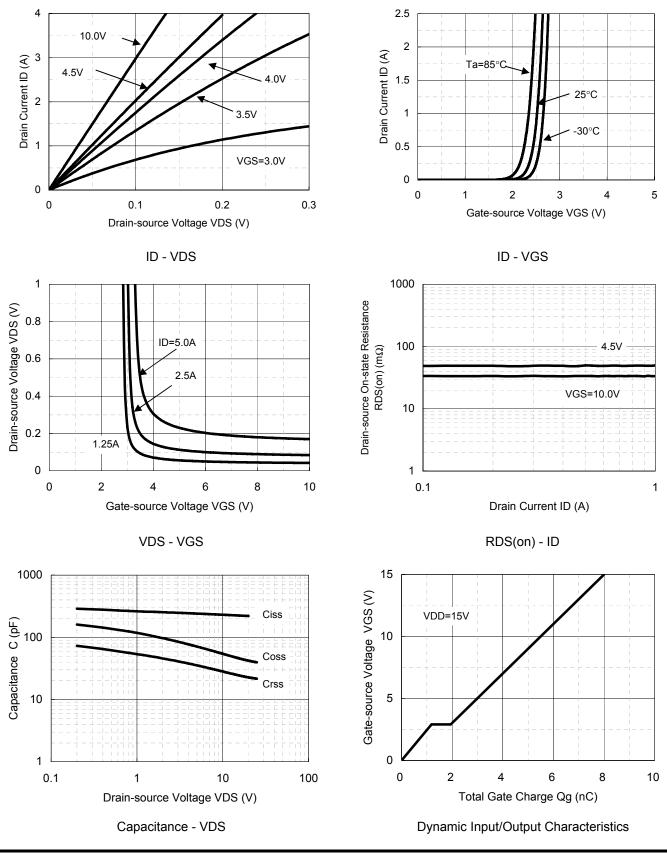
Diode Forward Voltage <sup>*1</sup>	VSD	IS = 2.5 A, VGS = 0 V		0.8	1.2	V
Note *1 Pulse test: Ensure that the channel temperature does not exceed 150 °C						

Pulse test: Ensure that the channel temperature does not exceed 150 °C ote

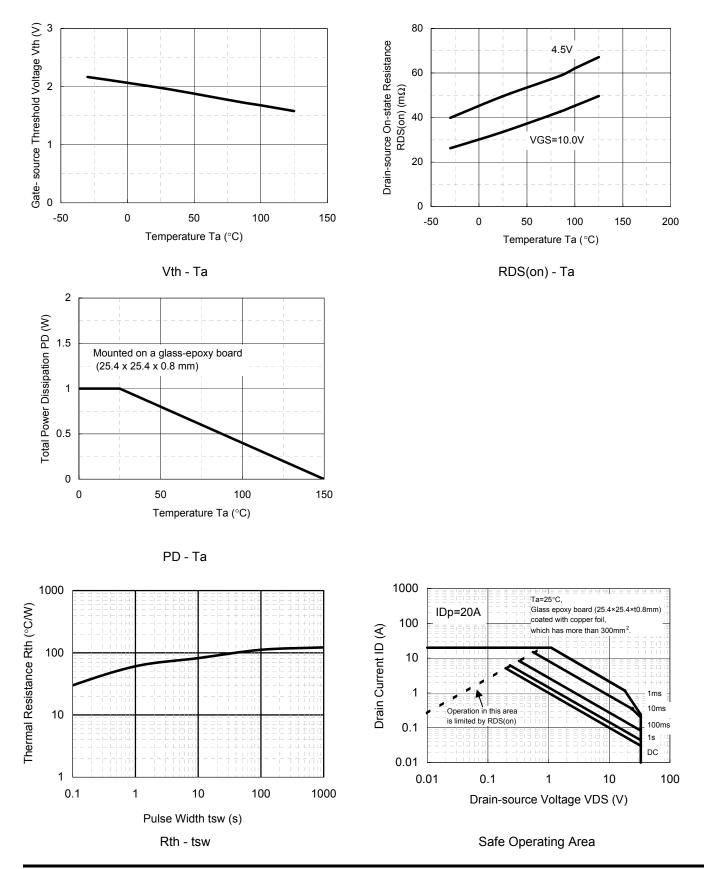


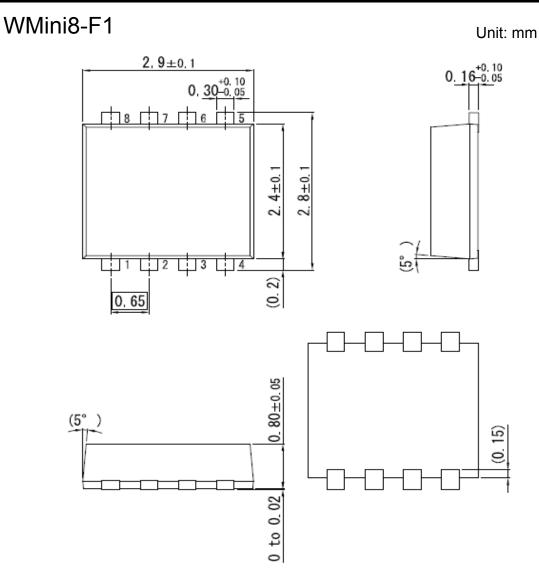
(Figure 2) Measuremet circuit for Turn-On Delay Time/Rise Time/Turn-Off Delay Time/Fall Time

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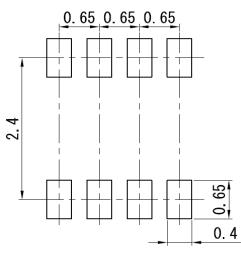


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■ Land Pattern (Reference) (Unit: mm)



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